



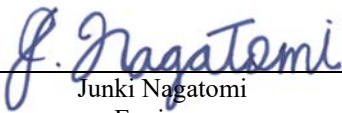
RADIO TEST REPORT


Test Report No. : 13565962H-A-R3

Applicant : silex technology, Inc.
Type of EUT : Wireless LAN SDIO module
Model Number of EUT : SX-SDMAN2
FCC ID : N6C-SDMAN2
Test regulation : **FCC Part 15 Subpart C: 2021**
*WLAN parts
*For Permissive Change
Radiated Emission test only
Test Result : **Complied (Refer to SECTION 3)**

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the limits of the above regulation.
4. The test results in this test report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by the A2LA accreditation body.
6. This test report covers Radio technical requirements.
It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
8. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.
9. The information provided from the customer for this report is identified in Section 1.
10. This report is a revised version of 13565962H-A-R2. 13565962H-A-R2 is replaced with this report.

Date of test: November 28 to December 1, 2020

Representative test engineer: 
Junki Nagatomi
Engineer
Consumer Technology Division

Approved by: 
Satofumi Matsuyama
Engineer
Consumer Technology Division



CERTIFICATE 5107.02

- The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
 There is no testing item of "Non-accreditation".

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
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REVISION HISTORY

Original Test Report No.: 13565962H-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13565962H-A	January 21, 2021	-	-
1	13565962H-A-R1	March 24, 2021	P 6	<p>Addition of Contents of the change from original model in Section 2.2: Product Description</p> <p>Bluetooth and WLAN 5 GHz (IEEE802.11a/n-20: U-NII-2C and IEEE802.11n-40) are disabled according to the customer's request.</p>
2	13565962H-A-R2	April 21, 2021	P 6	<p>Replacement to new sentence of contents of the change from original model in Section 2.2: Product Description</p>
2	13565962H-A-R2	April 21, 2021	P 6	<p>Deletion of "- 80 MHz Bandwidth (5610 MHz)" in Section 2.2: Product Description</p>
2	13565962H-A-R2	April 21, 2021	P 7	<p>Correction of FCC Part 15.31 (e) and FCC Part 15.203 Antenna requirement in Section 3.2.</p> <p><u>FCC Part 15.31 (e)</u> The stable voltage was provided to the EUT during the tests. Therefore, this EUT complies with the requirement.</p> <p><u>FCC Part 15.203 Antenna requirement</u> The EUT has an external antenna connector, but it is installed by the professionals. Therefore, the equipment complies with the antenna requirement of Section 15.203. →</p> <p><u>FCC 15.31 (e)</u> The RF Module has own regulator. The RF Module is constantly provided voltage through own regulator regardless of input voltage. Therefore, this EUT complies with the requirement.</p> <p><u>FCC Part 15.203/212 Antenna requirement</u> The EUT has a unique coupling/antenna connector (U.FL Alternative connector). Therefore the equipment complies with the requirement of 15.203/212.</p>
3	13565962H-A-R3	April 27, 2021	P 6	<p>Correction of below sentence of contents of the change from original model in Section 2.2: Product Description</p> <p>The test was performed only radiated emission test for WLAN 2.4 GHz (IEEE802.11b/g/n-20) and 5 GHz (IEEE802.11a/n-20: U-NII-1, U-NII-2A, U-NII-3) as the same power setting to the original report. →</p> <p>However, the radiated spurious emission test for WLAN 2.4 GHz (IEEE802.11b/g/n-20) and 5 GHz (IEEE802.11a/n-20: U-NII-1, U-NII-2A, U-NII-3) was performed using the same power setting to original test report, which is higher than the power setting of the host device as conservative conditions.</p>

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

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SECTION 1: Customer information

Company Name : silex technology, Inc.
Address : 2-3-1 Hikaridai, Seika-cho, Soraku-gun, Kyoto 619-0237, Japan
Telephone Number : +81-774-98-3878
Facsimile Number : +81-774-98-3758
Contact Person : Yoshinori Nakai

The information provided from the customer is as follows;

- Applicant, Type of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
 - Operating/Test Mode(s) (Mode(s)) on all the relevant pages
 - SECTION 1: Customer information
 - SECTION 2: Equipment under test (EUT) other than the Receipt Date
 - SECTION 4: Operation of EUT during testing
- * The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Type : Wireless LAN SDIO module
Model Number : SX-SDMAN2
Serial Number : Refer to SECTION 4.2
Rating : DC 3.3 V, DC 1.8 V
Receipt Date : November 24, 2020
Country of Mass-production : Japan
Condition : Production model
Modification : No Modification by the test lab.

2.2 Product Description

Model: SX-SDMAN2 (referred to as the EUT in this report) is a Wireless LAN SDIO module.

General Specification

Clock frequency(ies) in the system : 26 MHz
Operating Temperature : -20 deg. C - +85 deg. C

Radio Specification

Radio Type : Transceiver
Method of Frequency Generation : Synthesizer

	IEEE802.11b	IEEE802.11g/n (20 M band)	IEEE802.11a/n (20 M band)	IEEE802.11n (40 M band)	Bluetooth Ver.4.0 with EDR function
Frequency of operation	2412 MHz - 2462 MHz *1)	2412 MHz - 2462 MHz *1)	5180 MHz - 5240 MHz 5260 MHz - 5320 MHz 5500 MHz - 5700 MHz 5745 MHz - 5825 MHz	5190 MHz - 5230 MHz 5270 MHz - 5310 MHz 5510 MHz - 5670 MHz 5755 MHz - 5795 MHz	2402 MHz - 2480 MHz
Type of modulation	DSSS (CCK, DQPSK, DBPSK)	OFDM-CCK (64QAM, 16QAM, QPSK, BPSK)	OFDM (64QAM, 16QAM, QPSK, BPSK)		BT: FHSS (GFSK, $\pi/4$ -DQPSK, 8-DPSK) LE: GFSK
Channel spacing	5MHz		20MHz	40MHz	BT: 1MHz LE: 2MHz
Antenna type	PCB antenna				
Antenna Connector type	U.FL Alternative connector				
Antenna Gain	2.8 dBi (2.4GHz Band), 4.2 dBi (5GHz Band)				

*1) This test report applies to IEEE802.11b/g/n-20 (2412 MHz - 2462 MHz).

* Spurious emission test was performed with two antenna type (external antenna and chip antenna).

** WLAN and Bluetooth do not transmit simultaneously.

<Contents of the change from original model>

Test Report Number of original is 10748020H-B-R2 (issued by UL Japan, Inc.).

Specification was changed from the original as follows:

An antenna has been added to the EUT that only supports WLAN 2.4 GHz (IEEE802.11b/g/n-20) and 5 GHz (IEEE802.11a/n-20: U-NII-1, U-NII-2A, U-NII-3).

Host device equipped with this antenna disables Bluetooth and WLAN 5 GHz (IEEE802.11a/n-20: U-NII-2A, U-NII-2C and IEEE802.11n-40). Also, the power setting value has decreased.

However, the radiated spurious emission test for WLAN 2.4 GHz (IEEE802.11b/g/n-20) and 5 GHz (IEEE802.11a/n-20: U-NII-1, U-NII-2A, U-NII-3) was performed using the same power setting to original test report, which is higher than the power setting of the host device as conservative conditions.

*Following channels are not used in Canada.

- 20 MHz Bandwidth (5600 MHz - 5640 MHz)s

- 40 MHz Bandwidth (5590 MHz - 5630 MHz)

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on January 12, 2021 and effective February 11, 2021

Title : FCC 47 CFR Part 15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz,
and 5725-5850 MHz

* The revision does not affect the test result conducted before its effective date.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 15.247 Meas Guidance v05r02	FCC: Section15.247(d)	0.6 dB 2483.500 MHz, AV, Vert.	Complied# a)	Radiated (above 30 MHz) *1)
	ISED: RSS-Gen 6.13	ISED: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10			
Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.					
*1) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 15.247 Meas Guidance v05r02 8.5 and 8.6.					
a) Refer to APPENDIX 1 (data of Radiated Spurious Emission)					
Symbols:					
Complied		The data of this test item has enough margin, more than the measurement uncertainty.			
Complied#		The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.			

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC 15.31 (e)

The RF Module has own regulator.

The RF Module is constantly provided voltage through own regulator regardless of input voltage.

Therefore, this EUT complies with the requirement.

FCC Part 15.203/212 Antenna requirement

The EUT has a unique coupling/antenna connector (U.FL Alternative connector).

Therefore the equipment complies with the requirement of 15.203/212.

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.

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Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)
3 m	9 kHz to 30 MHz	3.3 dB
10 m		3.2 dB
3 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		5.0 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.2 dB
		6.3 dB
10 m	30 MHz to 200 MHz (Horizontal) (Vertical)	4.8 dB
		4.8 dB
	200 MHz to 1000 MHz (Horizontal) (Vertical)	5.0 dB
		5.0 dB
3 m	1 GHz to 6 GHz	4.9 dB
	6 GHz to 18 GHz	5.2 dB
1 m	10 GHz to 26.5 GHz	5.5 dB
	26.5 GHz to 40 GHz	5.5 dB
10 m	1 GHz to 18 GHz	5.2 dB

3.5 Test Location

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*A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 199967

ISED Lab Company Number: 2973C / CAB identifier: JP0002

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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SECTION 4: Operation of EUT during testing

4.1 Operating Mode(s)

Test operating mode was determined as follows according to “Section 1 of 6 802.11 a/b/g/n testing - Managing Complex Regulatory Approvals - ” of TCB Council Workshop October 2009.

Mode	Remarks*
IEEE 802.11b (11b)	11 Mbps, PN9
IEEE 802.11g (11g)	24 Mbps, PN9
IEEE 802.11n MIMO 20MHz BW (11n-20)	MCS 11 (Long GI), PN9
*The worst condition was determined based on the test result of Maximum Peak Output Power (Mid Channel).	
*Power of the EUT was set by the software as follows; - Power Setting: Refer to the following table - Software Name: athtestcmd - Software Version: ath6kl-v5.0 (Date: November 28, 2020, Storage location: Driven by connected PC)	
*This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.	

[Power setting: WLAN]

	Rate	Antenna port	Target Power	Power Setting		
				Antenna 1	Antenna 2	
11b	11Mbps (Long GI)	Antenna 1	2412 MHz	12.5	13	13
			2437 MHz	12.5	13	13
			2462 MHz	12.5	13	12.5
11g	24Mbps	Antenna 1	2412 MHz	7.5	7	7
			2417 MHz	9	10	10
			2422 MHz	10.5	12	12
			2437 MHz - 2447 MHz	12.5	13	13
			2452 MHz	11	12	12
			2457 MHz	10	10.5	10
11n20	MCS11 (Long GI)	Antenna 0+1	2412 MHz	5.5	5.5	5.5
			2417 MHz	7.5	9.5	9.5
			2422 MHz	10	11.5	11.5
			2437 MHz - 2447 MHz	12.5	13	13
			2452 MHz	10	12	12
			2457 MHz	8	10.5	10.5
			2462 MHz	6	6.5	6.5

*Above values of “Power Setting” were setting values in the test tool in order to output the Target power. Since the serial number of the product was different for antenna 1 and antenna 2, there were two different power setting values.

*The details of Operating mode(s)

Test Item	Operating Mode	Tested Antenna port	Tested frequency
Spurious Emission above 1GHz (Radiated)	11b Tx	1 *2)	2412MHz 2437MHz 2462MHz
	11g Tx	1 *2)	2412MHz 2462MHz
	11n-20 Tx	0+1	2412MHz 2437MHz 2462MHz
Spurious Emission below 1GHz (Radiated) *1)	11n-20 Tx	0+1	2437MHz
*1) The operating mode and tested frequency were tested as a representative, because it had the highest power at antenna terminal test. *2) After the comparison between Antenna port 0 and Antenna port 1, test was performed with the antenna that had higher power as a representative.			

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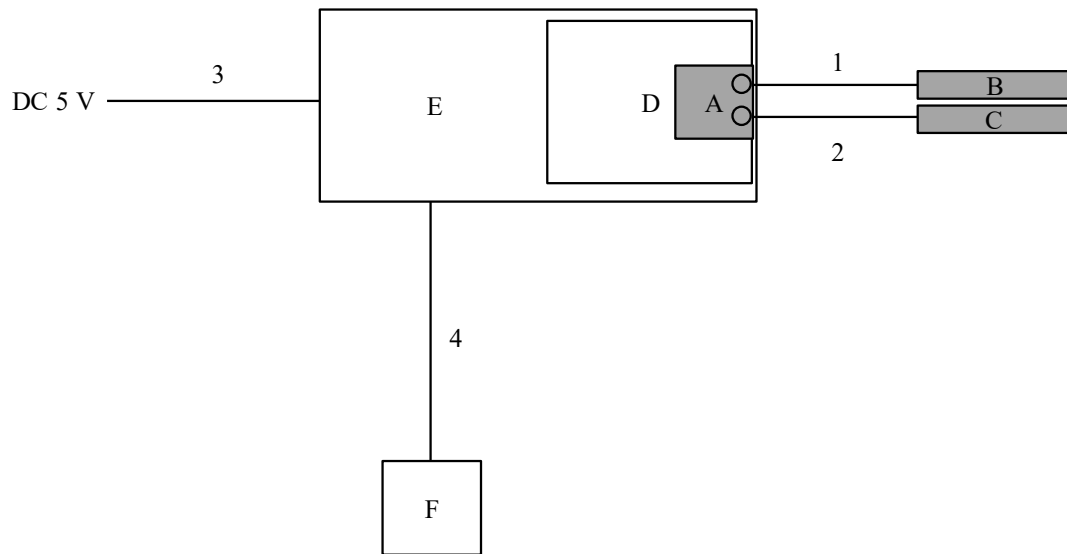
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4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Wireless LAN SDIO module	SX-SDMAN2	84253F0E60CB	silex technology, Inc.	EUT
B	WiFi dual band antenna	H2B1PD1A1C	001	Unictron Technologies Corporation	EUT
C	WiFi dual band antenna	H2B1PD1A1C	001	Unictron Technologies Corporation	EUT
D	Jig	SX-582	-	silex technology, Inc.	-
E	Jig	-	-	silex technology, Inc.	-
F	Jig	-	-	silex technology, Inc.	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	Antenna Cable	0.1	Shielded	Shielded	-
2	Antenna Cable	0.1	Shielded	Shielded	-
3	DC Cable	2.5	Unshielded	Unshielded	-
4	Signal Cable	1.8	Unshielded	Unshielded	-

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SECTION 5: Radiated Spurious Emission

Test Procedure

It was measured based on "8.5 and 8.6 of KDB 558074 D01 15.247 Meas Guidance v05r02".

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(ISED) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (ISED).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	<u>11.12.2.5.1</u> RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces <u>11.12.2.5.2</u> The duty cycle was less than 98% for detected noise, a duty factor was added to the 11.12.2.5.1 results.	RBW: 100 kHz VBW: 300 kHz

*1) Average Power Measurement was performed based on ANSI C63.10-2013.

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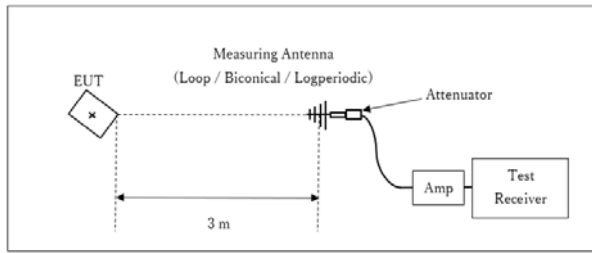
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Figure 2: Test Setup

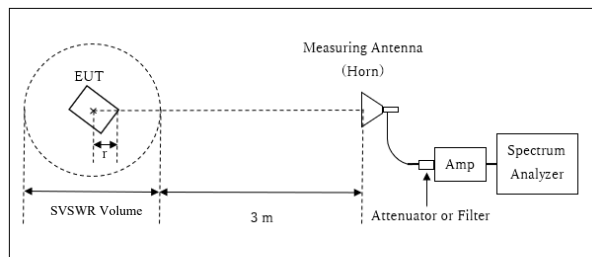
Below 1 GHz



× : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz

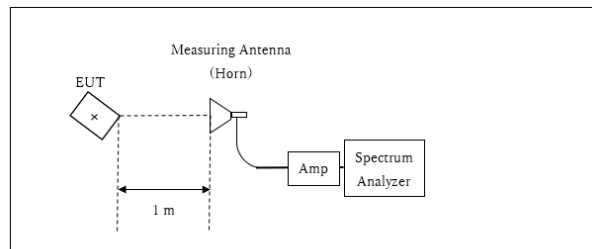


r : Radius of an outer periphery of EUT
 × : Center of turn table

Distance Factor: $20 \times \log(3.95 \text{ m} / 3.00 \text{ m}) = 2.39 \text{ dB}$
 * Test Distance: $(3 + \text{SVSWR Volume} / 2) - r = 3.95 \text{ m}$

SVSWR Volume : 2.00 m
 (SVSWR Volume has been calibrated based on CISPR 16-1-4.)
 $r = 0.05 \text{ m}$

10 GHz – 26.5 GHz



× : Center of turn table

Distance Factor: $20 \times \log(1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$
 *Test Distance: 1 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

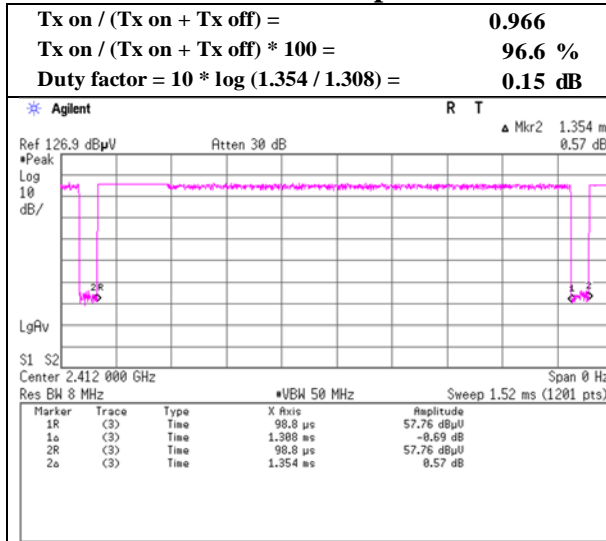
Measurement range : 30 MHz - 26.5 GHz
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test data

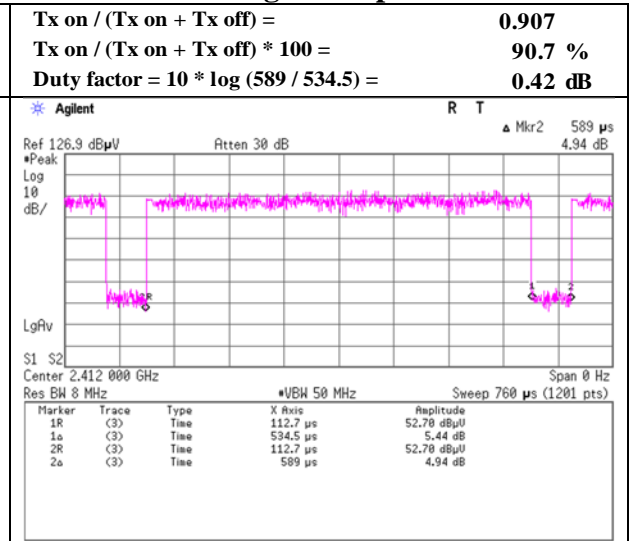
Burst rate confirmation

Report No. 13565962H
Test place Ise EMC Lab. No.3 Semi Anechoic Chamber
Date November 28, 2020
Temperature / Humidity 22 deg. C / 38 % RH
Engineer Takafumi Noguchi
Mode Tx

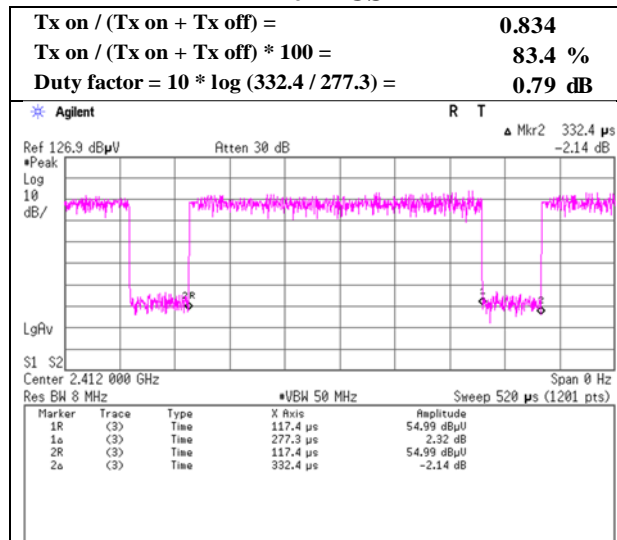
11b 11 Mbps



11g 24 Mbps



11n-20 MCS 11



* Since the burst rate is not different between the channels, the data has been obtained on the representative channel.

Radiated Spurious Emission

Report No.	13565962H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH
Engineer	Takafumi Noguchi (1 GHz - 10 GHz)	Junki Nagatomi (10 GHz - 18 GHz)	Junki Nagatomi (18 GHz - 26.5 GHz)
Mode	Tx 11b 2412 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2390.000	PK	48.4	27.5	5.5	32.7	-	48.7	73.9	25.2	
Hori.	4824.000	PK	45.0	31.7	7.6	31.7	-	52.6	73.9	21.3	
Hori.	7236.000	PK	43.6	36.1	9.0	32.6	-	56.0	73.9	17.9	Floor noise
Hori.	9648.000	PK	45.1	38.7	9.4	33.3	-	60.0	73.9	13.9	Floor noise
Hori.	2390.000	AV	39.3	27.5	5.5	32.7	0.2	39.8	53.9	14.1	*1)
Hori.	4824.000	AV	36.0	31.7	7.6	31.7	0.2	43.8	53.9	10.1	
Hori.	7236.000	AV	32.2	36.1	9.0	32.6	-	44.6	53.9	9.3	Floor noise
Hori.	9648.000	AV	33.0	38.7	9.4	33.3	-	47.9	53.9	6.0	Floor noise
Vert.	2390.000	PK	48.4	27.5	5.5	32.7	-	48.6	73.9	25.3	
Vert.	4824.000	PK	45.7	31.7	7.6	31.7	-	53.3	73.9	20.6	
Vert.	7236.000	PK	43.6	36.1	9.0	32.6	-	56.1	73.9	17.8	Floor noise
Vert.	9648.000	PK	45.1	38.7	9.4	33.3	-	60.0	73.9	14.0	Floor noise
Vert.	2390.000	AV	39.3	27.5	5.5	32.7	0.2	39.8	53.9	14.1	*1)
Vert.	4824.000	AV	36.5	31.7	7.6	31.7	0.2	44.2	53.9	9.7	
Vert.	7236.000	AV	32.2	36.1	9.0	32.6	-	44.6	53.9	9.3	Floor noise
Vert.	9648.000	AV	33.0	38.7	9.4	33.3	-	47.9	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.95\text{ m} / 3.0\text{ m}) = 2.39\text{ dB}$

10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

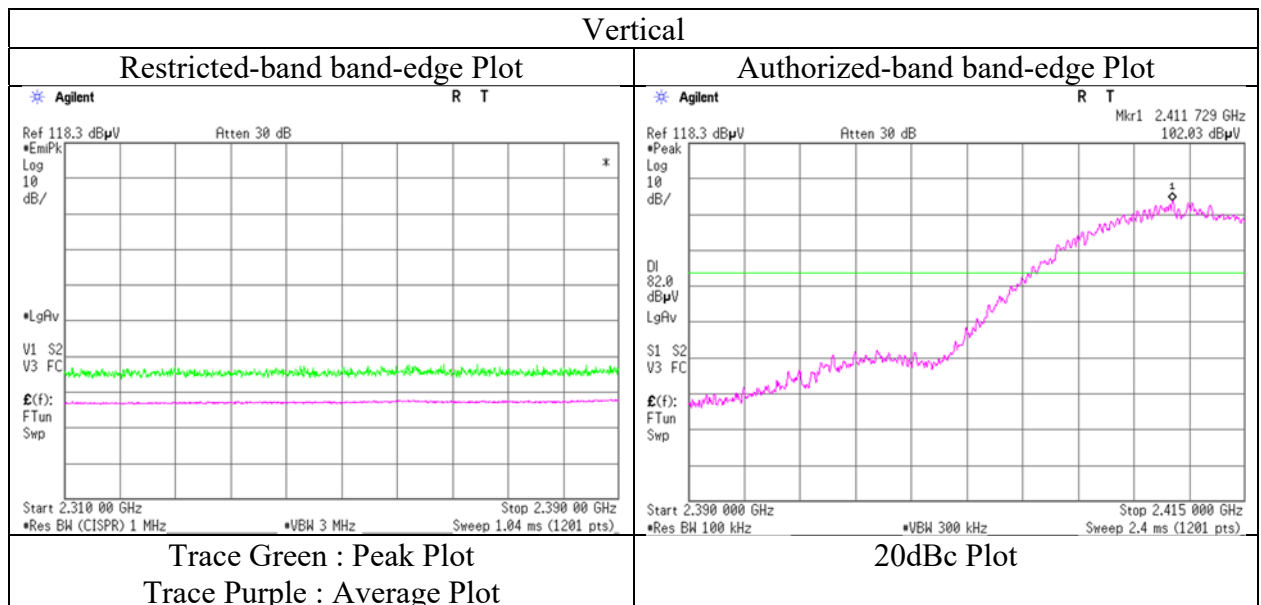
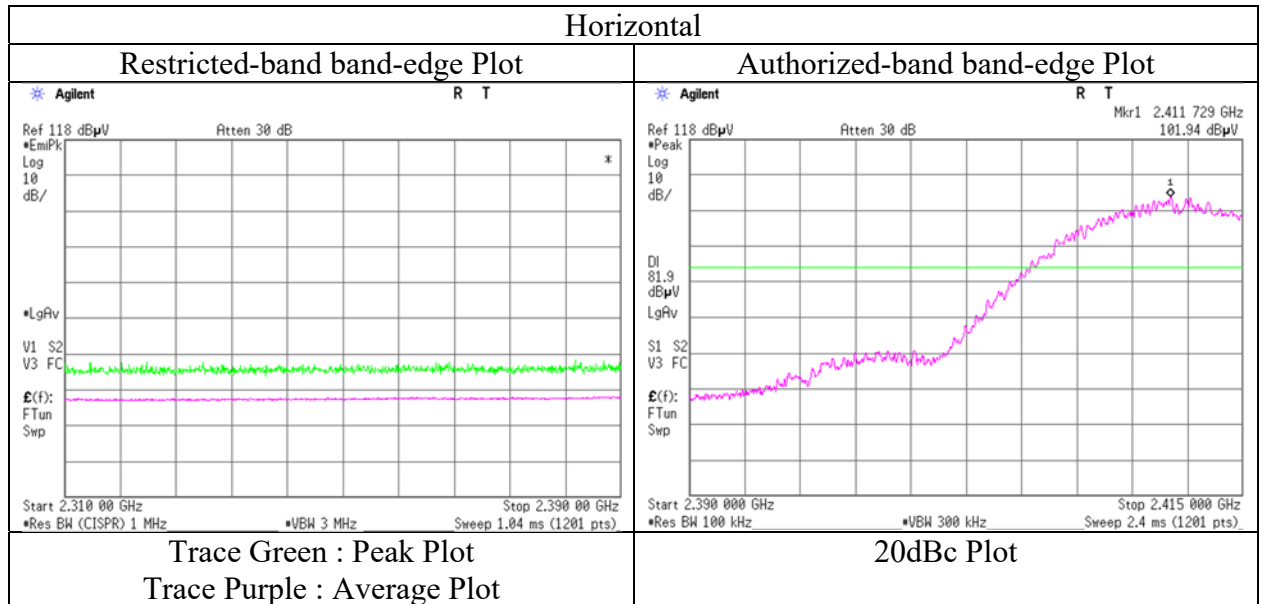
20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2412.000	PK	101.9	27.5	5.5	32.7	102.2	-	-	Carrier
Hori.	2398.583	PK	57.3	27.5	5.5	32.7	57.6	82.2	24.6	
Hori.	2400.000	PK	54.9	27.5	5.5	32.7	55.1	82.2	27.1	
Vert.	2412.000	PK	102.0	27.5	5.5	32.7	102.3	-	-	Carrier
Vert.	2398.583	PK	58.9	27.5	5.5	32.7	59.1	82.3	23.2	
Vert.	2400.000	PK	56.4	27.5	5.5	32.7	56.7	82.3	25.6	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Radiated Spurious Emission
(Reference Plot for band-edge)

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date November 28, 2020
Temperature / Humidity 22deg. C / 38 % RH
Engineer Takafumi Noguchi
(1 GHz - 10 GHz)
Mode Tx 11b 2412 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Radiated Spurious Emission

Report No.	13565962H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH
Engineer	Takafumi Noguchi (1 GHz - 10 GHz)	Junki Nagatomi (10 GHz - 18 GHz)	Junki Nagatomi (18 GHz - 26.5 GHz)
Mode	Tx 11b 2437 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4874.000	PK	45.2	31.5	7.6	31.6	-	52.6	73.9	21.3	
Hori.	7311.000	PK	43.9	36.2	9.0	32.6	-	56.4	73.9	17.5	Floor noise
Hori.	9748.000	PK	44.5	39.0	9.5	33.4	-	59.6	73.9	14.3	Floor noise
Hori.	4874.000	AV	36.0	31.5	7.6	31.6	0.2	43.6	53.9	10.3	
Hori.	7311.000	AV	31.9	36.2	9.0	32.6	-	44.4	53.9	9.5	Floor noise
Hori.	9748.000	AV	32.7	39.0	9.5	33.4	-	47.8	53.9	6.1	Floor noise
Vert.	4874.000	PK	45.3	31.5	7.6	31.6	-	52.8	73.9	21.1	
Vert.	7311.000	PK	43.9	36.2	9.0	32.6	-	56.4	73.9	17.5	Floor noise
Vert.	9748.000	PK	44.6	39.0	9.5	33.4	-	59.7	73.9	14.3	Floor noise
Vert.	4874.000	AV	36.1	31.5	7.6	31.6	0.2	43.8	53.9	10.1	
Vert.	7311.000	AV	31.9	36.2	9.0	32.6	-	44.4	53.9	9.5	Floor noise
Vert.	9748.000	AV	32.7	39.0	9.5	33.4	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.95\text{ m} / 3.0\text{ m}) = 2.39\text{ dB}$
 10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

Radiated Spurious Emission

Report No.	13565962H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH
Engineer	Takafumi Noguchi (1 GHz - 10 GHz)	Junki Nagatomi (10 GHz - 18 GHz)	Junki Nagatomi (18 GHz - 26.5 GHz)
Mode	Tx 11b 2462 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2483.500	PK	50.5	27.3	5.6	32.7	-	50.7	73.9	23.2	
Hori.	4924.000	PK	46.0	31.4	7.6	31.6	-	53.4	73.9	20.6	
Hori.	7386.000	PK	43.4	36.2	9.0	32.7	-	55.9	73.9	18.0	Floor noise
Hori.	9848.000	PK	44.8	38.9	9.5	33.4	-	59.7	73.9	14.2	Floor noise
Hori.	2483.500	AV	41.7	27.3	5.6	32.7	0.2	42.1	53.9	11.8	*1)
Hori.	4924.000	AV	36.7	31.4	7.6	31.6	0.2	44.3	53.9	9.6	
Hori.	7386.000	AV	31.4	36.2	9.0	32.7	-	43.9	53.9	10.0	Floor noise
Hori.	9848.000	AV	32.9	38.9	9.5	33.4	-	47.8	53.9	6.1	Floor noise
Vert.	2483.500	PK	50.4	27.3	5.6	32.7	-	50.5	73.9	23.4	
Vert.	4924.000	PK	46.5	31.4	7.6	31.6	-	53.8	73.9	20.1	
Vert.	7386.000	PK	43.5	36.2	9.0	32.7	-	56.0	73.9	17.9	Floor noise
Vert.	9848.000	PK	44.8	38.9	9.5	33.4	-	59.7	73.9	14.2	Floor noise
Vert.	2483.500	AV	41.6	27.3	5.6	32.7	0.2	41.9	53.9	12.0	*1)
Vert.	4924.000	AV	37.1	31.4	7.6	31.6	0.2	44.7	53.9	9.2	
Vert.	7386.000	AV	31.4	36.2	9.0	32.7	-	43.9	53.9	10.0	Floor noise
Vert.	9848.000	AV	32.9	38.9	9.5	33.4	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

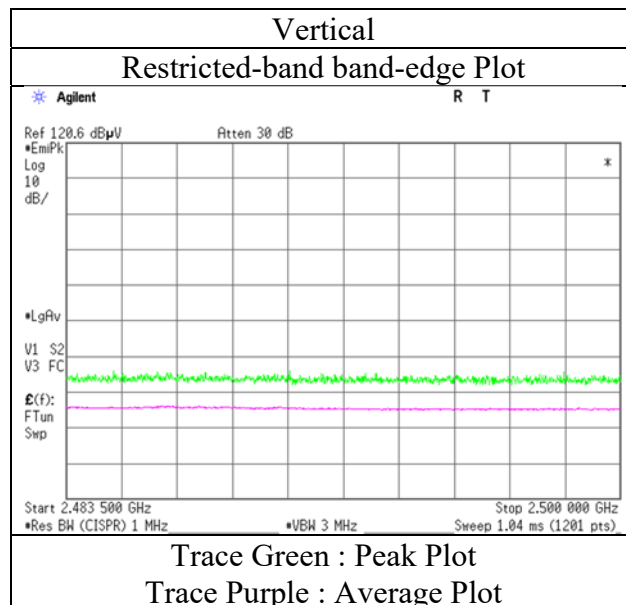
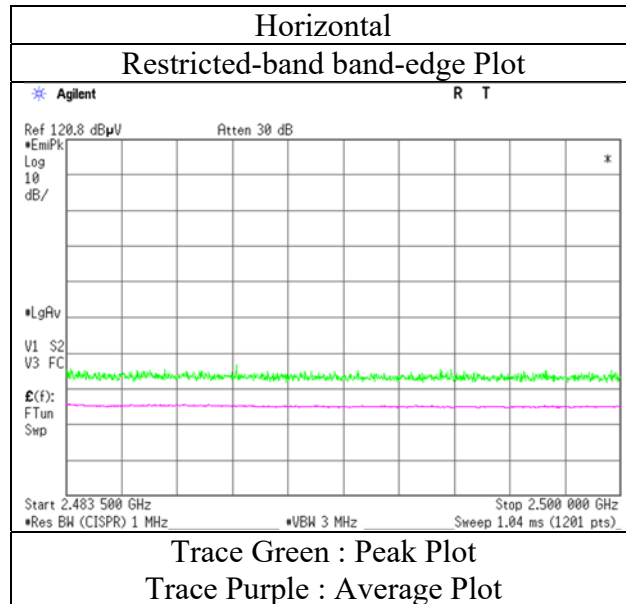
*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.95 m / 3.0 m) = 2.39 dB
 10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

Radiated Spurious Emission
(Reference Plot for band-edge)

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date November 28, 2020
Temperature / Humidity 22deg. C / 38 % RH
Engineer Takafumi Noguchi
(1 GHz - 10 GHz)
Mode Tx 11b 2462 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Report No.	13565962H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH
Engineer	Takafumi Noguchi (1 GHz - 10 GHz)	Junki Nagatomi (10 GHz - 18 GHz)	Junki Nagatomi (18 GHz - 26.5 GHz)
Mode	Tx 11g 2412 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2390.000	PK	59.0	27.5	5.5	32.7	-	59.3	73.9	14.7	
Hori.	2390.000	AV	47.6	27.5	5.5	32.7	0.4	48.3	53.9	5.6	*1)
Vert.	2390.000	PK	59.9	27.5	5.5	32.7	-	60.2	73.9	13.7	
Vert.	2390.000	AV	48.6	27.5	5.5	32.7	0.4	49.2	53.9	4.7	*1)

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.95\text{ m} / 3.0\text{ m}) = 2.39\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

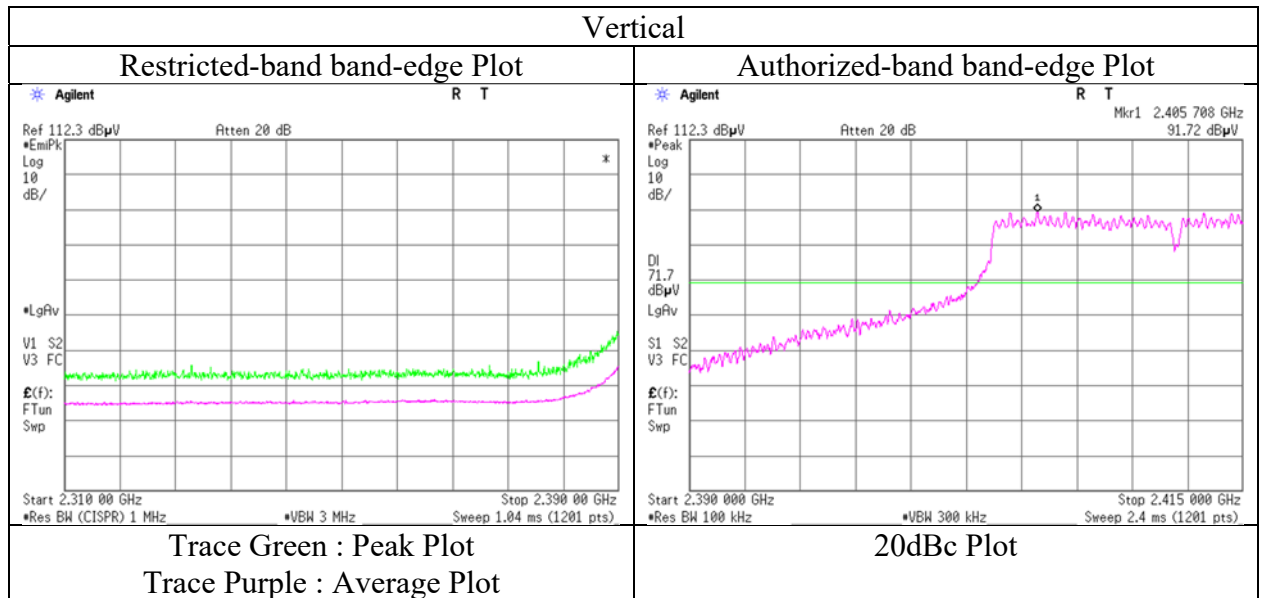
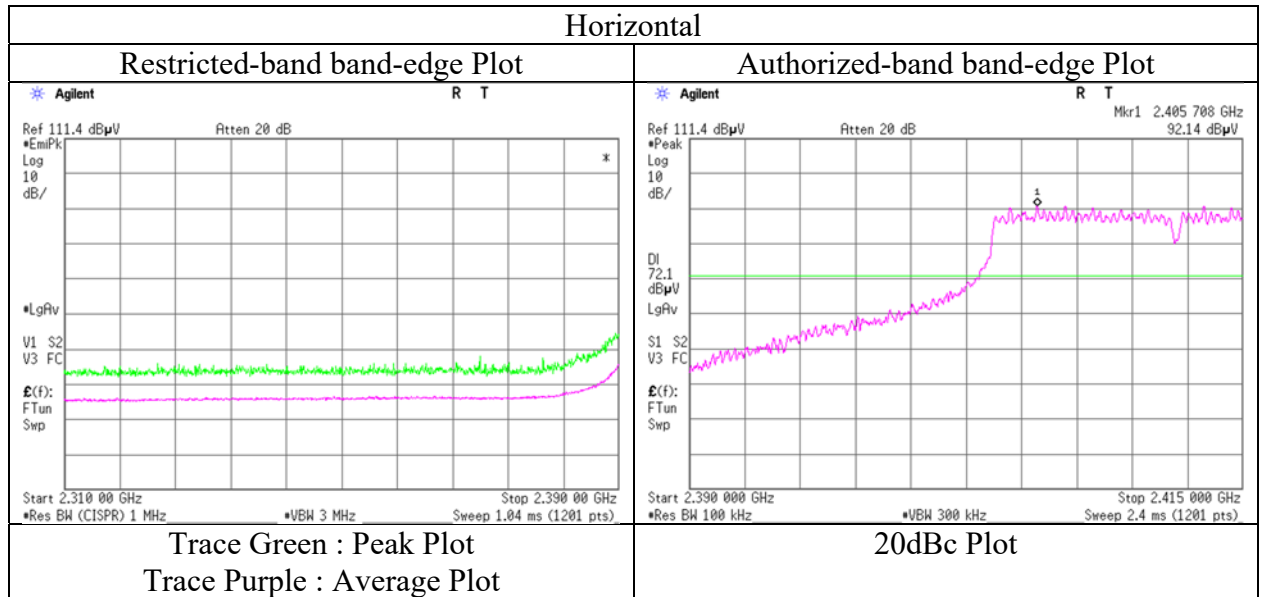
20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2412.000	PK	92.1	27.5	5.5	32.7	92.4	-	-	Carrier
Hori.	2400.000	PK	62.7	27.5	5.5	32.7	63.0	72.4	9.4	
Vert.	2412.000	PK	91.7	27.5	5.5	32.7	92.0	-	-	Carrier
Vert.	2400.000	PK	62.8	27.5	5.5	32.7	63.0	72.0	9.0	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Radiated Spurious Emission
(Reference Plot for band-edge)

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date November 28, 2020
Temperature / Humidity 22deg. C / 38 % RH
Engineer Takafumi Noguchi
(1 GHz - 10 GHz)
Mode Tx 11g 2412 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Report No.	13565962H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH
Engineer	Takafumi Noguchi (1 GHz - 10 GHz)	Junki Nagatomi (10 GHz - 18 GHz)	Junki Nagatomi (18 GHz - 26.5 GHz)
Mode	Tx 11g 2462 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2483.500	PK	64.0	27.3	5.6	32.7	-	64.2	73.9	9.7	
Hori.	2483.500	AV	52.4	27.3	5.6	32.7	0.4	53.0	53.9	0.9	*1)
Vert.	2483.500	PK	64.2	27.3	5.6	32.7	-	64.3	73.9	9.6	
Vert.	2483.500	AV	52.7	27.3	5.6	32.7	0.4	53.3	53.9	0.6	*1)

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

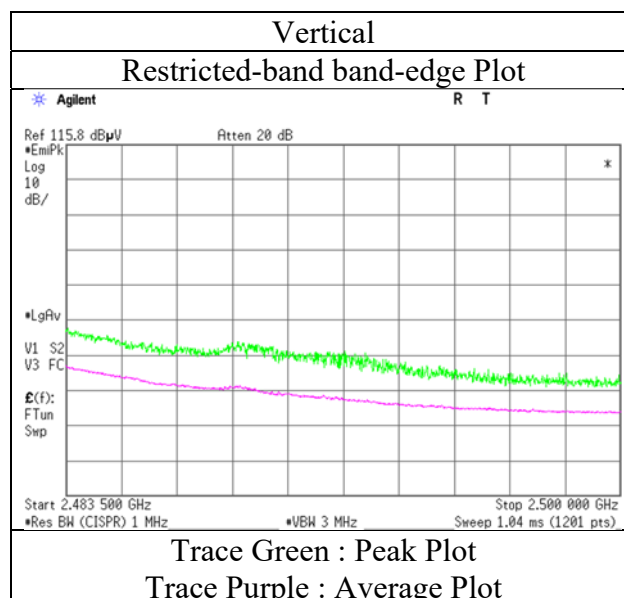
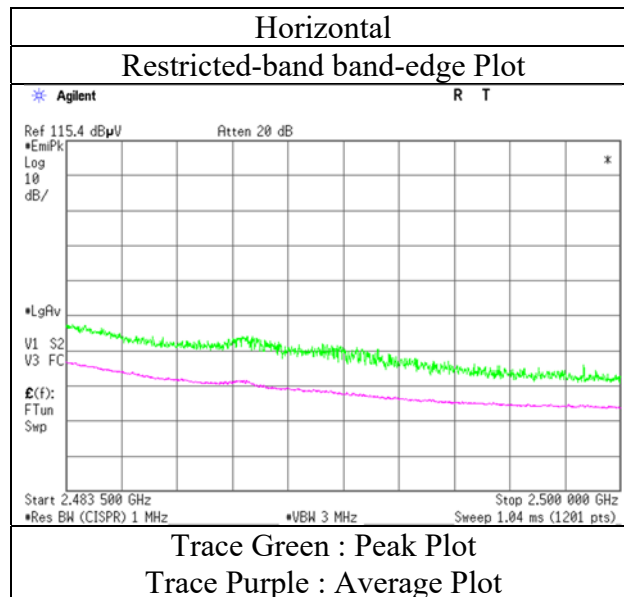
*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.95\text{ m} / 3.0\text{ m}) = 2.39\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

Radiated Spurious Emission
(Reference Plot for band-edge)

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date November 28, 2020
Temperature / Humidity 22deg. C / 38 % RH
Engineer Takafumi Noguchi
(1 GHz - 10 GHz)
Mode Tx 11g 2462 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.
Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3 No.3 No.3
Date November 28, 2020 November 30, 2020 December 1, 2020
Temperature / Humidity 22deg. C / 38 % RH 20deg. C / 35 % RH 21deg. C / 30 % RH
Engineer Takafumi Noguchi Junki Nagatomi Junki Nagatomi
(1 GHz - 10 GHz) (10 GHz - 18 GHz) (18 GHz - 26.5 GHz)
Mode Tx 11n-20 2412 MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2390.000	PK	61.6	27.5	5.5	32.7	-	61.8	73.9	12.1	
Hori.	4824.000	PK	42.2	31.7	7.6	31.7	-	49.8	73.9	24.1	Floor noise
Hori.	7236.000	PK	43.7	36.1	9.0	32.6	-	56.1	73.9	17.8	Floor noise
Hori.	9648.000	PK	45.2	38.7	9.4	33.3	-	60.0	73.9	13.9	Floor noise
Hori.	2390.000	AV	48.8	27.5	5.5	32.7	0.8	49.9	53.9	4.0	*1)
Hori.	4824.000	AV	31.3	31.7	7.6	31.7	-	38.9	53.9	15.1	Floor noise
Hori.	7236.000	AV	32.2	36.1	9.0	32.6	-	44.6	53.9	9.3	Floor noise
Hori.	9648.000	AV	33.0	38.7	9.4	33.3	-	47.9	53.9	6.0	Floor noise
Vert.	2390.000	PK	62.2	27.5	5.5	32.7	-	62.5	73.9	11.4	
Vert.	4824.000	PK	42.0	31.7	7.6	31.7	-	49.6	73.9	24.3	Floor noise
Vert.	7236.000	PK	43.7	36.1	9.0	32.6	-	56.1	73.9	17.8	Floor noise
Vert.	9648.000	PK	45.2	38.7	9.4	33.3	-	60.0	73.9	13.9	Floor noise
Vert.	2390.000	AV	49.7	27.5	5.5	32.7	0.8	50.8	53.9	3.1	*1)
Vert.	4824.000	AV	31.3	31.7	7.6	31.7	-	38.9	53.9	15.0	Floor noise
Vert.	7236.000	AV	32.2	36.1	9.0	32.6	-	44.6	53.9	9.3	Floor noise
Vert.	9648.000	AV	33.0	38.7	9.4	33.3	-	47.9	53.9	6.0	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.95\text{ m} / 3.0\text{ m}) = 2.39\text{ dB}$
10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

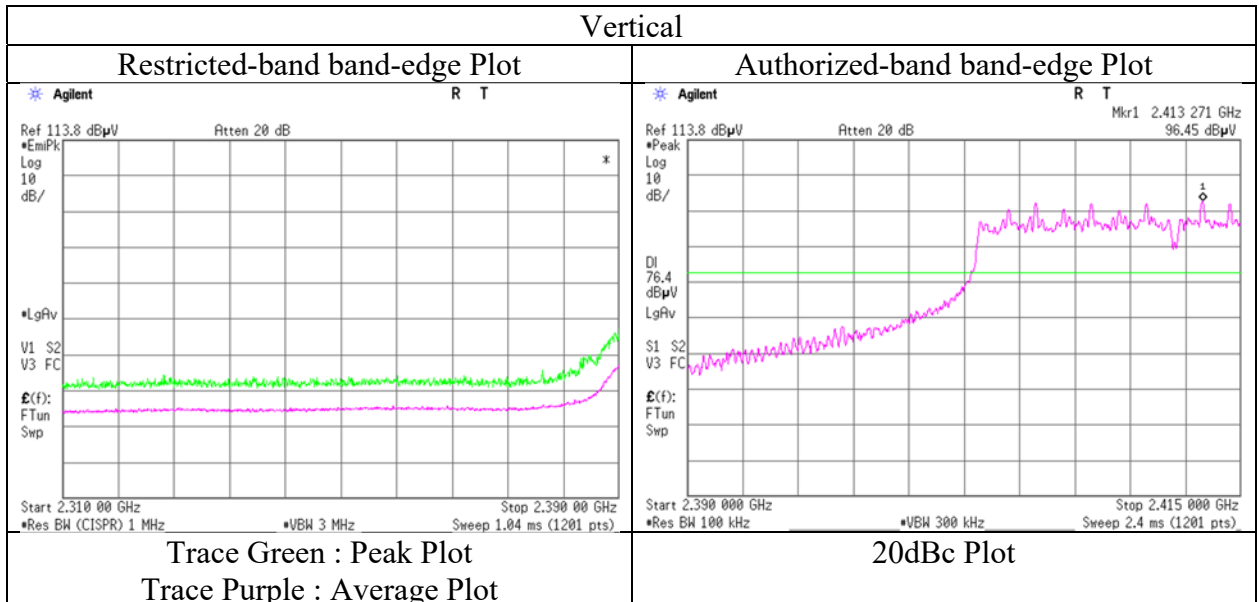
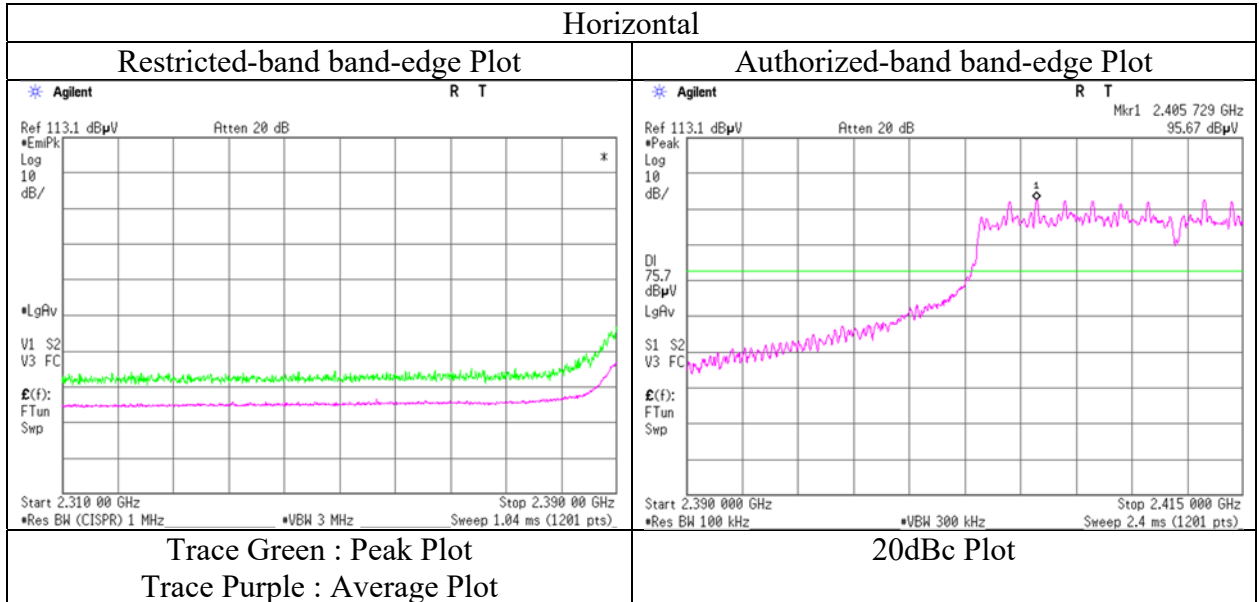
20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2412.000	PK	95.7	27.5	5.5	32.7	95.9	-	-	Carrier
Hori.	2400.000	PK	64.8	27.5	5.5	32.7	65.0	75.9	10.9	
Vert.	2412.000	PK	96.5	27.5	5.5	32.7	96.7	-	-	Carrier
Vert.	2400.000	PK	64.5	27.5	5.5	32.7	64.7	76.7	12.0	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

Radiated Spurious Emission
(Reference Plot for band-edge)

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date November 28, 2020
Temperature / Humidity 22deg. C / 38 % RH
Engineer Takafumi Noguchi
(1 GHz - 10 GHz)
Mode Tx 11n-20 2412 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Radiated Spurious Emission

Report No.	13565962H			
Test place	Ise EMC Lab.			
Semi Anechoic Chamber	No.3	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH	21deg. C / 35 % RH
Engineer	Takafumi Noguchi	Junki Nagatomi	Junki Nagatomi	Junya Okuno
	(1 GHz - 10 GHz)	(10 GHz - 18 GHz)	(18 GHz - 26.5 GHz)	(Below 1 GHz)
Mode	Tx 11n-20 2437 MHz			

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	132.000	QP	36.4	14.0	8.5	32.1	-	26.8	43.5	16.7	
Hori.	135.000	QP	36.2	14.3	8.6	32.1	-	27.0	43.5	16.6	
Hori.	300.000	QP	47.2	13.5	10.1	32.0	-	38.8	46.0	7.2	
Hori.	309.000	QP	43.4	13.6	10.1	32.0	-	35.2	46.0	10.8	
Hori.	617.138	QP	35.0	19.5	12.1	32.0	-	34.7	46.0	11.3	
Hori.	822.856	QP	29.0	20.9	13.2	31.3	-	31.7	46.0	14.3	
Hori.	4874.000	PK	41.9	31.5	7.6	31.6	-	49.3	73.9	24.6	Floor noise
Hori.	7311.000	PK	44.0	36.2	9.0	32.6	-	56.5	73.9	17.4	Floor noise
Hori.	9748.000	PK	44.4	39.0	9.5	33.4	-	59.5	73.9	14.4	Floor noise
Hori.	4874.000	AV	31.0	31.5	7.6	31.6	-	38.5	53.9	15.5	Floor noise
Hori.	7311.000	AV	32.0	36.2	9.0	32.6	-	44.5	53.9	9.4	Floor noise
Hori.	9748.000	AV	32.7	39.0	9.5	33.4	-	47.8	53.9	6.1	Floor noise
Vert.	39.320	QP	37.0	15.1	7.3	32.2	-	27.2	40.0	12.8	
Vert.	129.000	QP	38.1	13.7	8.5	32.1	-	28.2	43.5	15.3	
Vert.	132.000	QP	37.8	14.0	8.5	32.1	-	28.2	43.5	15.3	
Vert.	292.500	QP	41.2	13.6	10.0	32.0	-	32.8	46.0	13.2	
Vert.	300.000	QP	42.8	13.5	10.1	32.0	-	34.4	46.0	11.6	
Vert.	617.138	QP	29.2	19.5	12.1	32.0	-	28.9	46.0	17.1	
Vert.	4874.000	PK	41.9	31.5	7.6	31.6	-	49.3	73.9	24.6	Floor noise
Vert.	7311.000	PK	43.9	36.2	9.0	32.6	-	56.4	73.9	17.5	Floor noise
Vert.	9748.000	PK	44.5	39.0	9.5	33.4	-	59.6	73.9	14.3	Floor noise
Vert.	4874.000	AV	31.0	31.5	7.6	31.6	-	38.4	53.9	15.5	Floor noise
Vert.	7311.000	AV	31.9	36.2	9.0	32.6	-	44.4	53.9	9.5	Floor noise
Vert.	9748.000	AV	32.7	39.0	9.5	33.4	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.95 m / 3.0 m) = 2.39 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

Radiated Spurious Emission

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3 No.3 No.3
Date November 28, 2020 November 30, 2020 December 1, 2020
Temperature / Humidity 22deg. C / 38 % RH 20deg. C / 35 % RH 21deg. C / 30 % RH
Engineer Takafumi Noguchi Junki Nagatomi Junki Nagatomi
(1 GHz - 10 GHz) (10 GHz - 18 GHz) (18 GHz - 26.5 GHz)
Mode Tx 11n-20 2462 MHz

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2483.500	PK	63.5	27.3	5.6	32.7	-	63.7	73.9	10.2	
Hori.	4924.000	PK	42.1	31.4	7.6	31.6	-	49.5	73.9	24.5	Floor noise
Hori.	7386.000	PK	43.4	36.2	9.0	32.7	-	56.0	73.9	17.9	Floor noise
Hori.	9848.000	PK	44.7	38.9	9.5	33.4	-	59.6	73.9	14.3	Floor noise
Hori.	2483.500	AV	51.4	27.3	5.6	32.7	0.8	52.4	53.9	1.5	*1)
Hori.	4924.000	AV	30.2	31.4	7.6	31.6	-	37.6	53.9	16.4	Floor noise
Hori.	7386.000	AV	31.4	36.2	9.0	32.7	-	43.9	53.9	10.0	Floor noise
Hori.	9848.000	AV	32.9	38.9	9.5	33.4	-	47.8	53.9	6.1	Floor noise
Vert.	2483.500	PK	63.5	27.3	5.6	32.7	-	63.7	73.9	10.3	
Vert.	4924.000	PK	42.1	31.4	7.6	31.6	-	49.4	73.9	24.5	Floor noise
Vert.	7386.000	PK	43.5	36.2	9.0	32.7	-	56.0	73.9	17.9	Floor noise
Vert.	9848.000	PK	44.7	38.9	9.5	33.4	-	59.6	73.9	14.3	Floor noise
Vert.	2483.500	AV	51.4	27.3	5.6	32.7	0.8	52.4	53.9	1.5	*1)
Vert.	4924.000	AV	30.2	31.4	7.6	31.6	-	37.5	53.9	16.4	Floor noise
Vert.	7386.000	AV	31.4	36.2	9.0	32.7	-	43.9	53.9	10.0	Floor noise
Vert.	9848.000	AV	32.9	38.9	9.5	33.4	-	47.8	53.9	6.1	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

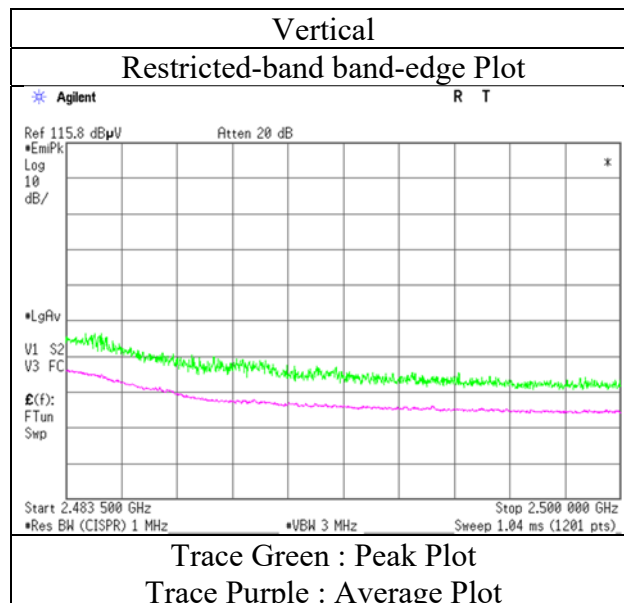
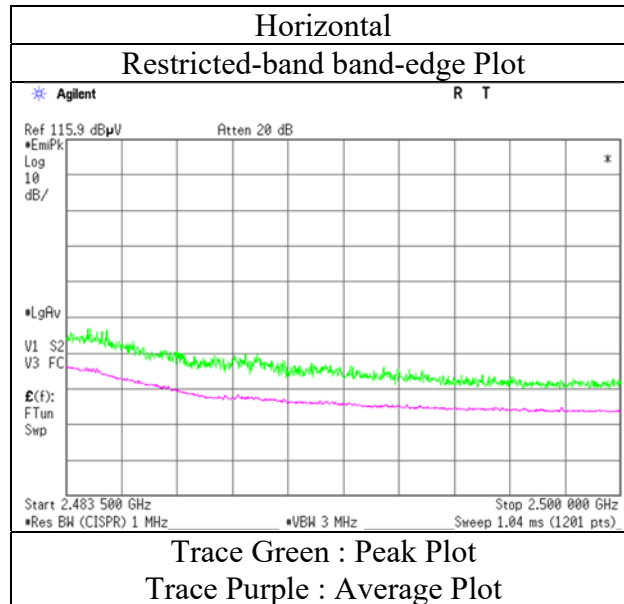
*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz $20\log(3.95\text{ m} / 3.0\text{ m}) = 2.39\text{ dB}$
10 GHz - 26.5 GHz $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.5\text{ dB}$

*1) Not Out of Band emission(Leakage Power)

Radiated Spurious Emission
(Reference Plot for band-edge)

Report No. 13565962H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.3
Date November 28, 2020
Temperature / Humidity 22deg. C / 38 % RH
Engineer Takafumi Noguchi
(1 GHz - 10 GHz)
Mode Tx 11n-20 2462 MHz



* The measurement was conducted for a sufficiently long enough time to detect any possible spurious emissions.

Final result of restricted band edge was shown in tabular data.

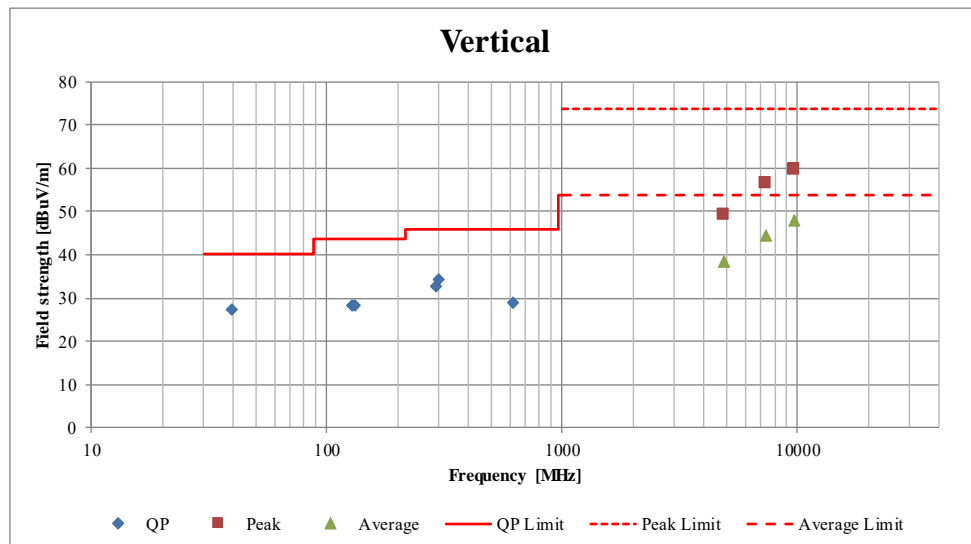
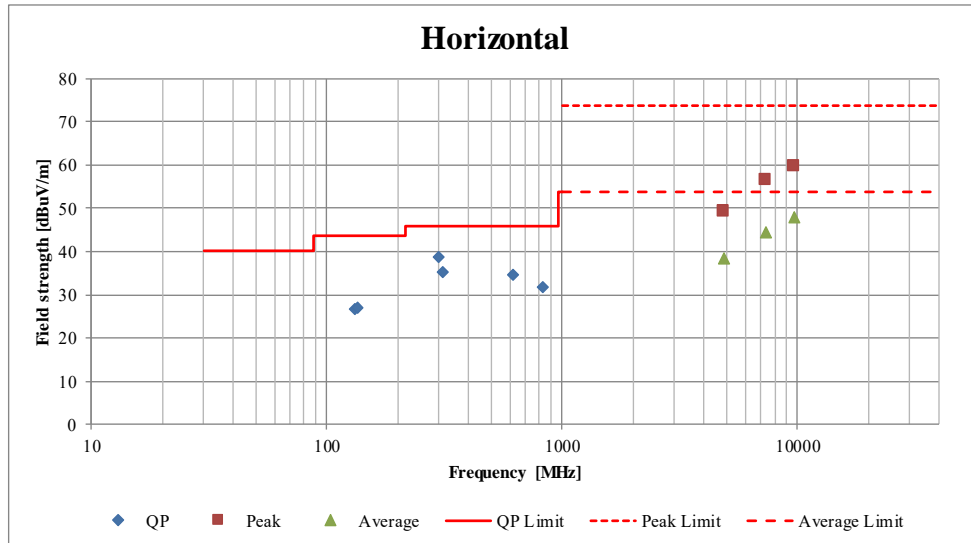
UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8999
Facsimile : +81 596 24 8124

Radiated Spurious Emission
(Plot data, Worst case)

Report No.	13565962H			
Test place	Ise EMC Lab.			
Semi Anechoic Chamber	No.3	No.3	No.3	No.3
Date	November 28, 2020	November 30, 2020	December 1, 2020	December 1, 2020
Temperature / Humidity	22deg. C / 38 % RH	20deg. C / 35 % RH	21deg. C / 30 % RH	21deg. C / 35 % RH
Engineer	Takafumi Noguchi (1 GHz - 10 GHz)	Junki Nagatomi (10 GHz - 18 GHz)	Junki Nagatomi (18 GHz - 26.5 GHz)	Junya Okuno (Below 1 GHz)
Mode	Tx 11n-20 2437 MHz			



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

APPENDIX 2: Test instruments

Test equipment

Test Item	Local ID	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	MOS-13	141554	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	1301	01/07/2020	12
RE	MMM-08	141532	DIGITAL HiTESTER	Hioki	3805	51201197	01/06/2020	12
RE	MJM-16	142183	Measure	KOMELON	KMC-36	-	-	-
RE	COTS-MEMI-02	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	MAEC-03-SVSWR	142013	AC3_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/08/2019	24
RE	MHA-20	141507	Horn Antenna 1-18GHz	Schwarzbeck Mess - Elektronik	BBHA9120D	258	10/01/2020	12
RE	MPA-11	141580	MicroWave System Amplifier	Keysight Technologies Inc	83017A	MY39500779	03/24/2020	12
RE	MCC-231	177964	Microwave Cable	Junkosha INC.	MMX221	1901S329(1m)/1902S579(5m)	03/02/2020	12
RE	MHF-25	141232	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	001	09/23/2020	12
RE	MSA-04	141885	Spectrum Analyzer	Keysight Technologies Inc	E4448A	US44300523	11/09/2020	12
RE	MAEC-03	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	05/22/2020	24
RE	MHA-16	141513	Horn Antenna 15-40GHz	Schwarzbeck Mess - Elektronik	BBHA9170	BBHA9170306	05/21/2020	12
RE	MAT-95	142314	Attenuator	Pasternack	PE7390-6	D/C 1504	06/17/2020	12
RE	MBA-03	141424	Biconical Antenna	Schwarzbeck Mess - Elektronik	VHA9103+BBA9106	1915	08/13/2020	12
RE	MCC-51	141323	Coaxial cable	UL Japan	-	-	07/06/2020	12
RE	MLA-22	141266	Logperiodic Antenna(200-1000MHz)	Schwarzbeck Mess - Elektronik	VUSLP9111B	9111B-191	08/13/2020	12
RE	MPA-13	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/10/2020	12
RE	MTR-08	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	08/18/2020	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item: RE: Radiated Emission test

UL Japan, Inc.

Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124